LIST OF ART CITED BY APPLICANT
(Use several sheets if necessary)APPLICANT
John T. MooreFILING DATE
June 22, 2000GROUP
2813

U.S. PATENT DOCUMENTS

*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
TSP	AA 6,100,163	08-2000	Jang et al.			
TSP	AB 6,399,520 B1	06-2002	Kawakami et al.			
	AC					
	AD					
	AE					
	AF					
	AG					
	AH					
	AI					
	AJ					
	AK					
	AL					

FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
	AM						
	AN						
	AO						
	AP						
	AO						

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

AR			
AS			
AT			

EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

IT 20

APR-04-2003 14:55

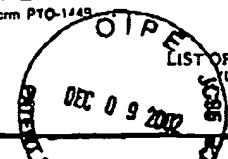
Form PTO-1449

WELLS ST JOHN PS

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

5098383424

P. 13

ATTY. DOCKN
4122-1342SERIAL NO.
09/62395

APPLICANT

John T. Moore

PILING DATE

June 22, 2000

09/62395

GROUP

2813

U.S. PATENT DOCUMENTS

Examiner Initials	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
TSP	AA 5,837,598	11/1998	Aronowitz et al.			
TSP	AB 6,450,110	09/2001	Noble et al.			
TSP	AC 4,605,447	08/1986	Bretherton et al.			
TSP	AD 6,207,586	03/2001	Ma et al.			
TSP	AF 5,177,592	11/1995	Chang et al.			
TSP	AG 3,334,554	08/1994	Liu et al.			
TSP	AH 6,197,161	10/2001	Jiang et al.			
TSP	AI 6,007,592-D1	03/2001	Liu et al.			
AI						
AJ						
AK						
AL						

RECEIVED
DEPT. OF COMMERCE
TECHNOLOGY CENTER 2813
DEC 3 2002
2002

FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Subclass	Translation
						Yes
AM						
AN						
AO						
AP						
AO						

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

AR		
AS		
AT		

EXAMINER:

DATE CONSIDERED

1/13/02

"EXAMINER: Initial if reference considered, whether or not citation is in conformance with STEP 6B; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant."

LIST OF ART CITED BY APPLICANT
(Use several sheets if necessary)

APPLICANT

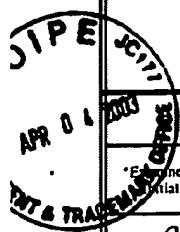
John T. Moore

FILING DATE

June 22, 2000

GROUP

2813



U.S. PATENT DOCUMENTS

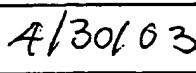
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
TSF	AA	6,410,991 B1	06/2002	Kawai et al.			
TSF	AB	6,482,690 B2	11/2002	Shibata			
TSF	AC	6,492,690 B2	12/2002	Ueno et al.			
	AD						
TSF	AE	US2001/0034518A1	02/2003	Yoshikawa			May 17, 2001
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						

FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AM							
	AN							
	AO							
	AP							
	AQ							

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

	AR							
	AS							
	AT							

EXAMINER DATE CONSIDERED 

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

RECEIVED
APR - 8
2003
TECHNOLOGY CENTER 2800

OIPE
LIST OF ARTICLES BY APPLICANT
(Use several sheets if necessary)

FEB 24 2003

APPLICANT

John T. Moore

FILING DATE

June 22, 2000

GROUP

2813

25

PATENT DOCUMENTS

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
TSP	AA	6,413,881 B1	07-2002	Aronowitz et al.			
TSP	AB	6,110,780	08-2000	Yu et al.			
TSP	AC	5,861,651	01-1999	Brasen et al.			
TSP	AD	5,840,610	11-1998	Gilmer et al.			
TSP	AE	5,500,380	03-1996	Kim			
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						

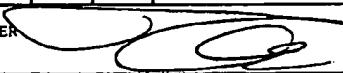
FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Subclass	Translation
						Yes No
	AM					
	AN					
	AO					
	AP					
	AQ					

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

	AR					
	AS					
	AT					

RECEIVED
TECHNOLOGY CENTER 2800
MAR 3 2003

EXAMINER  DATE CONSIDERED 4/30/03

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered.
Include copy of this form with next communication to applicant.